

Notice of References Cited	Application/Control No. 10/659,762	Applicant(s)/Patent Under Reexamination WARILA ET AL.	
	Examiner Isaac T. Tecklu	Art Unit 2192	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0067485	04-2003	Wong et al.	345/747
*	B	US-6,941,520	09-2005	Lewallen, Stephen Richard	715/762
*	C	US-6,707,475	03-2004	Snyder, Mark I.	715/771
*	D	US-6,754,676	06-2004	Dietz et al.	707/104.1
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	K	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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